## Search Notes



Application/Control No.	Applicant(s)/Patent Under Reexamination
10561719	AHN, JAE-WAN
Examiner	Art Unit
YOGESH PATEL	3732

SEARCHED							
Class	Subclass	Date	Examiner				
433	28	3/7/2008	YP				
137	613	3/7/2008	YP				
433	84	3/3/2008	YP				
222	146.5, 146.2	3/3/2008	YP				
604	208-210	3/3/2008	YP				
433	80-89	3/3/2008	YP				
433	32-37	3/10/2008	YP				

SEARCH NOTES				
Search Notes	Date	Examiner		
Inventor Name Search, Int'l search report, Assistance from Primary	3/10/2008	YP		
Examiner, Google Patents, Word search in class 219				
STIC search	3/3/2008	YP		

INTERFERENCE SEARCH						
Class	Subclass	Date	Examiner			

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